

Notice of References Cited

Application/Control No.

09/802,482

Applicant(s)/Patent Under
Reexamination
WEGERICH ET AL.

Examiner

Paul L Kim

Art Unit

2857

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5067099	11-1991	McCown et al	702/183
	B	US-6418431 B1	07-2002	Mahajan et al	707/4
	C	US-6202038 B1	03-2001	Wegerich et al	702/183
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	Rajan et al, Jan. 1998; "Machine Learning Algorithm for Fault Diagnosis in Analog Circuits", p1874-1879
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.